INFORMATION
DISCLOSURE
CITATION

Applicant: Takemi MUROGA et al

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| \ <b>E</b> |        | رقم U.S. PA       | TENT DOCUMENTS   |                     |
|------------|--------|-------------------|------------------|---------------------|
| Examiner   | Salter | Document Number - | Publication Date | Name of Patentee or |
| Initials*  | 110    | Kind Code         | MM-DD-YYYY       | Applicant           |
| CL         | AA     | 2002/0076567 A1   | 06-20-2002       | HONJO et al         |
|            | AB     |                   |                  |                     |
|            | AC     | <del></del>       |                  |                     |
|            | AC     |                   |                  |                     |

FOREIGN PATENT DOCUMENTS

| Examiner<br>Initials* | Cite<br>No. | Country Code -<br>Document Number -<br>Kind Code | Publication Date<br>MM-DD-YYYY | Name of Patentee or<br>Applicant | Trans. |
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| CL                    | AD          | EP 1 195 819 A1                                  | 04-10-2002                     | BELOUET                          |        |
| CC                    | AE          | WO 03/044836 A2                                  | 05-30-2003                     | HOLESINGER et al                 |        |
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|                       | AG          |  |                                |                                  |        |

NON PATENT LITERATURE DOCUMENTS

| Examiner<br>Initials* | Cite<br>No. | (Include Author, Title, Date, Pages, Etc.)   |
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| CL                    | АН          | Deposition of CeO <sub>2</sub> /YSZ buffer layer on Hastelloy substrates for MOD process of YBa <sub>2</sub> Cu <sub>3</sub> O <sub>7-x</sub> film, by Hiroshi Fuji et al, Physica C, vol. 357-360, August 2001, pages 1101-1014   |
|                       | AI          | In-plane aligned YBa <sub>2</sub> Cu <sub>3</sub> O <sub>7-x</sub> thin films deposited on polycrystalline metallic substrates, by Y. Iijima et al, Applied Physics Letters, vol. 60, no. 6, February 1992, pages 769-771  |
|                       | ΑĴ          | The effect of a MgO seed layer on the biepitaxial growth of Y <sub>1</sub> Ba <sub>2</sub> Cu <sub>3</sub> O <sub>7-x</sub> overlayers in various multilayered thin films, by SangSuk Lee et al, Thin Solid Films, vol. 258, no. 1/2, March 1995, pages 299-304                                    |
|                       | AK          | Growth and characterization of superconducting films TI <sub>0.78</sub> Bi <sub>0.22</sub> SR <sub>1.6</sub> Ba <sub>0.4</sub> Ca <sub>2</sub> Cu <sub>3</sub> O, on CeO <sub>2</sub> -buffered single crystal YSZ, by Z.F. Ren et al, Physica C, vol. 306, no. 1-2, September 1998, pages 149-153 |
| CC                    | AL          | Fabrication of YBa <sub>2</sub> Cu <sub>3</sub> O <sub>7-x</sub> Films of Buffered Metal Tapes<br>Fired at Low Temperature by MOD Method using<br>Trifluoroacetate Salts, by T. Araki et al, IEEE<br>Transactions on Applied Superconductivity, vol. 11, no. 1,<br>March 2001, pages 2869-2872     |
| EXAMINER              | SIGNA       | DATE CONSIDERED 7/10/06  |

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.